Search Notes

_	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/844,107	HAYASHI ET AL.
	Examiner	Art Unit
	Taus T. Chuses	2170

SEARCHED					
Class	Subclass	Date	Examiner		
Updated	Search	10/26/2005	тс		
715	835				
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	850	10/27/2005	TC		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
See Prin "Search	t out Note"	02/20/06	Tu	

SEARCH NOT (INCLUDING SEARCH) .
	DATE	EXMR
EAST (USPAT, USPG-PUB, DERWENT, EPO, JPO, USORC, IBM_TDB)	10/26/2005	тс
NPL (IEEE)	10/27/2005	тс
Committed with Pri. Buthynh for Allowability	02/16/06 X 02/20/06	
EAST (USPAT, USPG_PUB, DERWENT, EPO, TPO, VSOCR, IBM_TDB)	02/20/06	u
NPL(IEEE)	02/16/06	u